Search Notes



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Reexamination NAKAMURA, TOSHIO

Applicant(s)/Patent Under

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Strieb, Michael A

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SEARCHED

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SEARCH NOTES

Search Notes	Date	Examiner
Met with Benny Tieu	08/30/2007	M
Met with Sam Walk	8/30/2007	7AS
EAST text search	8/31/2007	MAS

INTERFERENCE SEARCH

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